

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/812,076	LEE ET AL.
	Examiner	Art Unit
	Cheukfan Lee	2625

SEARCHED			
Class	Subclass	Date	Examiner
358	475,486, 461	4/8/2007	C.L.
	497,494		
	474,409		
	412,505		
	509,527		
382	274		
	312		
	318,319		
250	234-236		
399	207		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
358	461	4/8/2007	C.L.
	474,475		
	497		